SCES041A - JULY 1995 - REVISED NOVEMBER 1996

56 10E2

- Member of the Texas Instruments
 Widebus ™ Family
- EPIC ™ (Enhanced-Performance Implanted CMOS) Submicron Process
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 250 mA Per JEDEC Standard JESD-17
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- Package Options Include Plastic 300-mil Shrink Small-Outline (DL) and Thin Shrink Small-Outline (DGG) Packages

description

This 20-bit non-inverting buffer/driver is designed for 2.3-V to 3.6-V V_{CC} operation.

The SN74ALVCH16827 is composed of two 10-bit sections with separate output-enable signals. For either 10-bit buffer section, the two output-enable (10E1 and 10E2 or 20E1 and 20E2) inputs must both be low for the corresponding Y outputs to be active. If either output-enable input is high, the outputs of that 10-bit buffer section are in the high-impedance state.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

1Y1 <u>|</u>|2 55 1 1A1 1Y2 54 L 1A2 GND 4 53 GND 52 1 1A3 1Y3 U5 51 1 1A4 1Y4 **∐**6 50 ∐ V_{CC} ∨_{CC} <u>Ц</u>7 1Y5 🛮 8 49 1 1A5 48 🗓 1A6 1Y6 **∐** 9 10 47 **∐** 1A7 1Y7 46 [] GND GND 11

DGG OR DL PACKAGE

(TOP VIEW)

10E1

45 🛮 1A8 1Y8 12 44 🛮 1A9 1Y9 13 1Y10 114 43 🛮 1A10 42 🛮 2A1 2Y1 15 2Y2 41 2A2 16 2Y3 17 40 D 2A3 39 | GND GND 18 38 🛮 2A4 2Y4 **1**19 2Y5 120 37 D 2A5

2Y9 26 31 2A9 2Y10 27 30 2A10 2OE1 28 29 2OE2

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

The SN74ALVCH16827 is available in TI's shrink small-outline (DL) and thin shrink small-outline (DGG) packages, which provide twice the I/O pin count and functionality of standard small-outline packages in the same printed circuit board area.

The SN74ALVCH16827 is characterized for operation from -40°C to 85°C.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

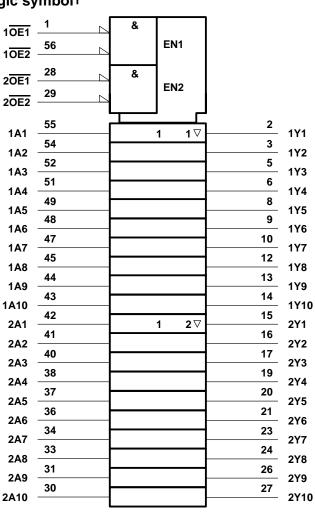
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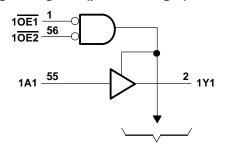
FUNCTION TABLE (each 10-bit section)

	INPUTS	ОИТРИТ	
OE1	OE2	Α	Y
L	L	L	L
L	L	Н	Н
Н	X	Χ	Z
Х	Н	Χ	Z

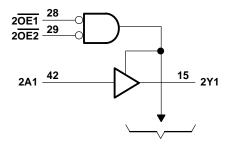
logic symbol†



logic diagram (positive logic)



To Nine Other Channels



To Nine Other Channels



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}	
Input voltage range, V _I (see Note 1)	
Output voltage range, V _O (see Notes 1 and 2)	0.5 V to V _{CC} + 0.5 V
Input clamp current, I_{IK} ($V_I < 0$)	
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	±50 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±50 mA
Continuous current through each V _{CC} or GND	±100 mA
Maximum power dissipation at $T_A = 55^{\circ}$ C (in still air) (see Note 3): DG	G package 1 W
DL	package1.4 W
Storage temperature range, T _{stg}	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
 - 2. This value is limited to 4.6 V maximum.
 - 3. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils. For more information, refer to the *Package Thermal Considerations* application note in the *ABT Advanced BiCMOS Technology Data Book*.

recommended operating conditions (see Note 4)

			MIN	MAX	UNIT
Vcc	Supply voltage		2.3	3.6	V
	High-level input voltage $\frac{V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}}{V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}}$		1.7		V
VIH			2		V
V	Low lovel input voltage	V _{CC} = 2.3 V to 2.7 V		0.7	V
V _{IL}	Low-level input voltage $V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$			0.8	V
٧ _I	Input voltage		0	VCC	V
٧o	Output voltage		0	VCC	V
		V _{CC} = 2.3 V		-12	
IOH	High-level output current	V _{CC} = 2.7 V		-12	mA
		V _{CC} = 3 V		-24	
		V _{CC} = 2.3 V		12	
lOL	Low-level output current	V _{CC} = 2.7 V	,		mA
			24		
Δt/Δν	Input transition rise or fall rate		0	10	ns/V
T _A	Operating free-air temperature		-40	85	°C

NOTE 4: Unused control inputs must be held high or low to prevent them from floating.



electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PAI	RAMETER	TEST CO	NDITIONS	VCC	MIN	TYP [†]	MAX	UNIT	
		$I_{OH} = -100 \mu\text{A}$		2.3 V to 3.6 V	V _{CC} -0.	2			
		$I_{OH} = -6 \text{ mA},$ $V_{IH} = 1.7 \text{ V}$		2.3 V	2				
\/a			V _{IH} = 1.7 V	2.3 V	1.7			٧	
VOH		I _{OH} = -12 mA	V _{IH} = 2 V	2.7 V	2.2			V	
			V _{IH} = 2 V	3 V	2.4				
		$I_{OH} = -24 \text{ mA},$	V _{IH} = 2 V	3 V	2				
		I _{OL} = 100 μA		2.3 V to 3.6 V			0.2		
		$I_{OL} = 6 \text{ mA},$	$V_{IL} = 0.7 V$	2.3 V			0.4		
VOL		lo. – 12 mA	V _{IL} = 0.7 V	2.3 V			0.7	V	
		I _{OL} = 12 mA	V _{IL} = 0.8 V	2.7 V			0.4		
		I _{OL} = 24 mA,	V _{IL} = 0.8 V	3 V			0.55		
lį		$V_I = V_{CC}$ or GND		3.6 V			±5	μΑ	
		$V_{I} = 0.7 \text{ V}$ $V_{I} = 1.7 \text{ V}$		2.3 V	45				
				2.3 V	-45				
I _{I(hold)}		V _I = 0.8 V		3 V	75			μΑ	
		V _I = 2 V		3 V	-75				
		$V_1 = 0 \text{ to } 3.6 \text{ V}^{\ddagger}$		3.6 V			±500		
loz		$V_O = V_{CC}$ or GND		3.6 V			±10	μΑ	
ICC		$V_I = V_{CC}$ or GND,	IO = 0	3.6 V			40	μΑ	
∆lcc		One input at V _{CC} – 0.6 V,	Other inputs at V _{CC} or GND	3 V to 3.6 V			750	μΑ	
C	Control inputs	VI - Voo or GND		3.3 V	221/	3.5		nE.	
Ci	Data inputs	V _I = V _{CC} or GND		3.3 V		6		pF	
Co	Outputs	$V_O = V_{CC}$ or GND		3.3 V		7.5		pF	

switching characteristics over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figures 1 and 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 2.5 V ± 0.2 V		V _{CC} = 2.7 V		V _{CC} = 3.3 V ± 0.3 V		UNIT	
		(INFOT)	(001701)	MIN	MAX	MIN	MAX	MIN	MAX	
	^t pd	А	Υ	1	4.7		3.9	1	3.4	ns
	t _{en}	ŌĒ	Υ	1	6.5		5.7	1	4.7	ns
	^t dis	ŌĒ	Υ	1.9	5.8		4.9	1.3	4.5	ns

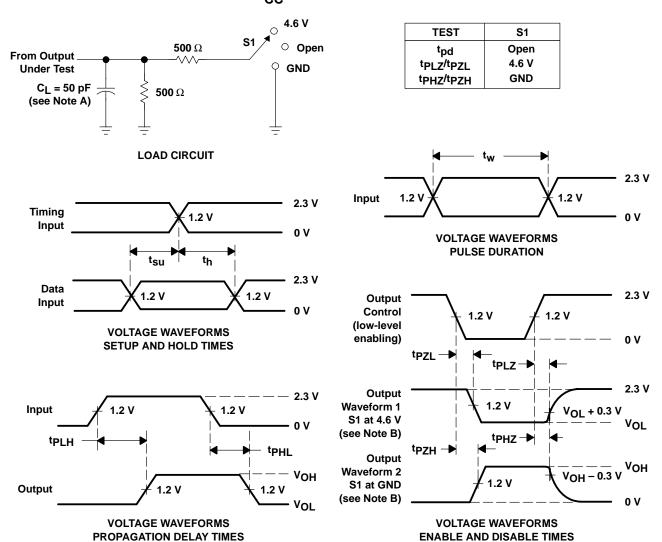
operating characteristics, $T_A = 25^{\circ}C$

PARAMETER			TEST CONDITIONS	V_{CC} = 2.5 V \pm 0.2 V	V _{CC} = 3.3 V ± 0.3 V	UNIT	
				TYP	TYP		
C _{pd}	Dower dissination conscitones	Outputs enabled	C _L = 50 pF, f = 10 MHz	16	18	pF	
	Power dissipation capacitance	Outputs disabled		4	6	þΓ	



[†] Typical values are measured at V_{CC} = 3.3 V, T_A = 25°C. ‡ This is a bus-hold maximum dynamic current required to switch the input from one state to another.

PARAMETER MEASUREMENT INFORMATION V_{CC} = 2.5 V \pm 0.2 V



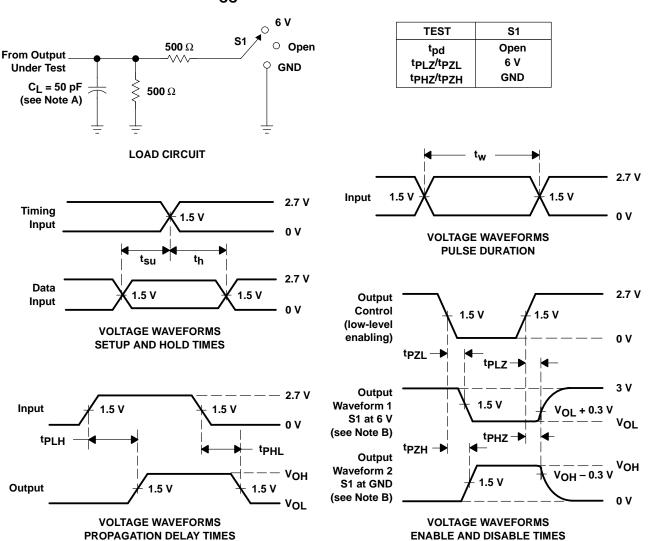
NOTES: A. C_I includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_Q = 50 \Omega$, $t_f \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpl 7 and tpH7 are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. tpLH and tpHL are the same as tod.

Figure 1. Load Circuit and Voltage Waveforms



PARAMETER MEASUREMENT INFORMATION V_{CC} = 2.7 V AND 3.3 V \pm 0.3 V



- NOTES: A. C_I includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50 \Omega$, $t_f \leq$ 2.5 ns, $t_f \leq$ 2.5 ns,
 - D. The outputs are measured one at a time with one transition per measurement.
 - E. tpl 7 and tpH7 are the same as tdis.
 - F. tpzL and tpzH are the same as ten.
 - G. tpLH and tpHL are the same as tpd.

Figure 2. Load Circuit and Voltage Waveforms



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